The University of Michigan Radiation Laboratory 3228 EECS Building Ann Arbor, MI 48109-2122 Tel: (734) 647-1792

Measured Radio Frequency Emissions From

Lectron RFA-XA Receiver PN(GM): 10418726

Report No. 415031-944 July 10, 1998

For: Lectron Products, Inc. 1400 S. Livernois Rochester Hills, MI 48307

Contact: John Prainito Tel: (248) 608-7352 Fax: (248) 656-2621

PO: Verbal

Measurements made by:

Tests supervised by: Report approved by:

Valdis V. Liepa Research Scientist

# Summary

Tests for compliance with FCC Regulations subject to Part 15, Subpart B, were performed on Lectron superregenerative RFA-XA receiver. This device is subject to Rules and Regulations as a Receiver. As a Digital Device it is exempt, but such measurements were made to assess the receiver's overall emissions.

Joseph D.Brunett

Valdis V. Liepa

In testing performed on July 6, 1998, the device tested in the worst case met the specifications for radiated emissions by 10.1 dB (see p. 6). The line conductive emission tests do not apply, since the device is powered from an automotive 12 VDC source.

EXHIBIT & Page 1-10 of 10
U of Mich file 415031- 944

#### 1. Introduction

Lectron RFA-XA receiver, PN(GM): 10418726, was tested for compliance with FCC Regulations, Part 15, adopted under Docket 87-389, April 18, 1989. The tests were performed at the University of Michigan Radiation Laboratory Willow Run Test Range following the procedures described in ANSI C63.4-1992 "Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz". The attenuation characteristics of the Open Site facility are on file with FCC Laboratory, Columbia, Maryland. (FCC file 31040/SIT)

### 2. Test Procedure and Equipment Used

The test equipment commonly used in our facility is listed in Table 2.1 below. The second column identifies the specific equipment used in these tests. The HP 8593E spectrum analyzer is used for primary amplitude and frequency reference.

Table 2.1. Test Equipment.

Test Instrument	Equipment Used	Manufacturer/Model	Cal. Date/By
Spectrum Analyzer		Hewlett-Packard 8593A	July 1997/HP
(9kHz-22GHz)		SN: 3107A01358	
Spectrum Analyzer	: X	Hewlett-Packard 8593E	June 1997/HP
(9kHz-26GHz)		SN: 3107A01131	
Spectrum Analyzer		Hewlett-Packard 182T/8558B	August 1996/U of M Rad Lab
(0.1-1500 MHz)		SN: 1529A01114/543592	
Preamplifier	X	Watkins-Johnson	May 1996/U of M Rad Lab
(5-1000MHz)		A11 -1 plus A25-1S	N 1000/11 CMD 11 1
Preamplifier	X	Avantek	Nov. 1992/ U of M Rad Lab
(5-4000 MHz)		TT 1 . TO 1 . 1400 !	A 1000MI CMID-LI-L
Power Meter		Hewlett-Packard 432A	August 1989/U of M Rad Lab
w/ Thermistor		Hewlett-Packard 478A	August 1989/U of M Rad Lab
Broadband Bicone	X	University of Michigan	July 1988/U of M Rad Lab
(20-200 MHz)	17	Titul and a Children	Lune 1006/II of M Dad Lab
Broadband Bicone	X	University of Michigan	June 1996/U of M Rad Lab
(200-1000 MHz		TT 1	Lune 1006/II of M Dod I ob
Dipole Antenna Ser		University of Michigan	June 1996/U of M Rad Lab
(25-1000 MHz)		EMCO 2121C	June 1996/U of M Rad Lab
Dipole Antenna Se		EMCO 3121C	June 1990/U of M Rad Lab
(30-1000 MHz)		SN: 992	December 1993/ EMCO
Active Loop Anten		EMCO 6502	December 1993/ EMCO
(0.090-30MHz)		SN: 2855	December 1993/EMCO
Active Rod		EMCO 3301B	December 1993/EMCO
(30Hz-50 MHz)		SN: 3223	February 1991/U of M Rad Lab
Ridge-horn Antenr (0.5-5 GHz)	na X	University of Michigan	reducity 1991/0 of W Rad Lab
LISN Box		University of Michigan	May 1994/U of M Rad Lab
	X	Assorted	January 1993/U of M Rad Lab
Signal Cables	Λ	Hewlett-Packard 7046A	During Use/U of M Rad Lab
X-Y Plotter		Hewlett-Packard 8656A	January 1990/U of M Rad Lab
Signal Generator		Hewiett-rackatu oojoA	January 1990/O Of W Rad Lab
(0.1-990 MHz) Printer	X	Hewlett-Packard 2225A	August 1989/HP
rimer	Λ	newiett-rackard 2223A	August 1707/111

# 3. Configuration and Identification of Device Under Test

The DUT is a 315.0 MHz superregenerative receiver, designed for onboard automobile security/convenience applications, and as such, it is powered from an automotive 12 VDC source. It is housed in a plastic case approximately 3.0 by 3.0 by 1.0 inches. Antenna is internal. For testing, a 3 meter long section of actual harness was used. In the receiver digital section, the decoding, signal processing, etc. are performed by a microprocessor timed by a 3.68 MHz oscillator.

The DUT was designed and manufactured by Lectron Products Inc., 1400 S. Livernois,

Rochester Hills, MI 48307. It is identified as:

Lectron Receiver PN(GM): 10418726 SN: 30 FCC ID: ABO0232R CANADA: 218 102 884

#### 3.1 Modifications Made

There were no modifications made to the DUT by this laboratory.

#### 4. Emission Limits

The DUT tested falls under Part 15, Subpart B, "Unintentional Radiators". The pertinent test frequencies, with corresponding emission limits, are given in Tables 4.1 and 4.2 below and Section 4.3.

#### 4.1 Radiated Emission Limits

Table 4.1. Radiated Emission Limits (Ref: 15.33, 15.35, 15.109).

Freq. (MHz)	E <sub>lim</sub> (3m) μV/m	E <sub>lim</sub> dB(μV/m)
30-88	100	40.0
88-216	150	43.5
216-960	200	46.0
960-2000	500	54.0

Note:

Quasi-Peak readings apply to 1000 MHz (120 kHz BW) Average readings apply above 1000 MHz (1 MHz BW)

#### 4.2 Line Conducted Emission Limits

Table 4.2. Conducted Emission Limits (Ref: 15.107).

Freq. (MHz)	μV	dB(μV)
0.450 - 1.705	250	48.0
1.705 - 30.0	250	48.0

Note:

Ouasi-Peak readings apply here

#### 4.3 Antenna Power Conduction Limits

Ref: 15.111(a). Pmax = 2 nW; for frequency range see Table 4.1.

#### 5. Emission Tests and Results

NOTE: Even though the FCC and/or Industry Canada specify that both the radiated and conductive emissions be measured using the Quasi-Peak and/or average detection schemes, we normally use peak detection since especially the Quasi-Peak is cumbersome to use with our instrumentation. In case the measurement fails to meet the limits, or the measurement is near the limit, it is remeasured using appropriate detection. We note, that since the peak detected signal is always higher or equal to the Quasi-Peak or average detected signal, the margin of compliance may be better, but not worse, than indicated in this report. The type of detection used is indicated in the data table, Table 5.1.

## 5.1 Anechoic Chamber Radiated Emission Tests

To familiarize with the radiated emission behavior of the DUT, it was studied and measured in the shielded anechoic chamber. In the chamber there is a set-up similar to that of an outdoor 3-meter site, with turntable, antenna mast, and a ground plane. Instrumentation includes spectrum analyzers and other equipment as needed.

To study and test for radiated emissions, the DUT was powered by a laboratory power supply at 13.6 VDC. A 315 MHz CW signal was injected (radiated) from a nearby signal generator using a short wire antenna. The DUT was taped to a syrofoam block and placed on the test table on each of the three axis. At each orientation, the table was rotated to obtain maximum signal for vertical and horizontal emission polarizations. This sequence was repeated throughout the required frequency range.

In the chamber we studied and recorded all the emissions using a ridge-horn antenna, which covers 200 MHz to 5000 MHz, up to 2 GHz. In scanning from 30 MHz to 2.0 GHz, there were no spurious emissions observed other than the LO, the injection signal, and the LO harmonics. Figures 5.1 and 5.2 show emissions measured 0-1000 MHz and 1000-2000 MHz, respectively. These measurements are made with a ridge-horn antenna at 3m, with spectrum analyzer in peak hold mode and the receiver rotated in all orientations. The measurements up to 1000 MHz (Fi.g. 5.1) are used for initial evaluation only, but those above 1000 MHz (Fig. 5.2) are used in final assessment for compliance.

#### 5.2 Open Site Radiated Emission Tests

The DUT was then moved to the 3 meter Open Field Test Site where measurements were repeated up to 1000 MHz using a small bicone, or dipoles when the measurement is near the limit. The DUT was excersized as described in Sec. 5.1 above. The measurements were made with a spectrum analyzer using 120 kHz IF bandwidth and peak detection mode, and, when appropriate, using Quasi-Peak or average detection (see 5.0). Figure 5.3 shows the DUT on the test table, and figure 5.4 shows the table oriented with respect to antenna for the worst case emissions for measurement at "fundamental".

The emissions from digital circuitry were measured on the Open Site using a standard bicone. These results are also given in Table 5.1.

# 5.3 Computations and Results for Radiated Emissions

To convert the dBm's measured on the spectrum analyzer to  $dB(\mu V/m)$ , we use expression

$$E_3(dB\mu V/m) = 107 + P_R + K_A - K_G$$

where PR = power recorded on spectrum analyzer, dB, measured at 3m

 $K_A$  = antenna factor, dB/m

KG = pre-amplifier gain, including cable loss, dB

When presenting the data, at each frequency the highest measured emission under all of the possible orientations is given. Computations and results are given in Table 5.1. There we see that the DUT meets the limit by 10.1 dB.

# **5.4 Conducted Emission Tests**

These tests do not apply, since the DUT is powered from a 12 V automotive battery.

#### 6. Other Measurements

**6.1 Emission Spectrum Near Fundamental** 

Near operating frequency the emission spectrum is measured typically over 50 MHz span with and without injection signal. These data are taken with the DUT close to antenna and, hence, amplitudes are relative. The plots are shown in Figure 6.1.

**6.2 Effect of Supply Voltage Variation** 

The DUT has been designed to operate from 12 VDC power. Using a spectrum analyzer, relative radiated emissions were recorded at the "fundamental" (316MHz) as voltage was varied from 6.0 to 18.0 VDC. Figure 6.2 shows the emission variation.

**6.3 Operating Voltage and Current** 

V = 12.5 VI = 1.7 mADC

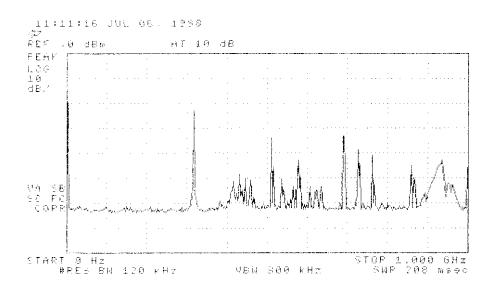
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Table 5.1 Highest Emissions Measured

	Radiated Emission - RF Lectron XA, RX; FC										
	Freq.	Ant.	Ant.	Pr	Det.	Ka	Kg	E3	E3lim	Pass	
#	MHz	Used	Pol.	dBm	Used	dB/m	dB	dBμV/m	dΒμV/m	dB	Comments
1	314.5	Dip	Н	-72.5	Pk	18.9	23.2	30.2	46.0	15.8	flat
2	314.5	Dip	Н	-66.8	Pk	18.9	23.2	35.9	46.0	10.1	side
3	314.5	Dip	Н	-67.8	Pk	18.9	23.2	34.9	46.0	11.1	end
4	314.5	Dip	V	-73.9	Pk	18.9	23.2	28.8	46.0	17.2	flat
5	314.5	Dip	V	-69.9	Pk	18.9	23.2	32.8	46.0	13.2	side
6	314.5	Dip	V	-70.2	Pk	18.9	23.2	32.5	46.0	13.5	end
7	630.0	Dip	V/H	-89.1	Pk	25.2	19.9	23.3	46.0	22.7	max. of all, noise; 10 kHz BW
8	945.0	Dip	V/H	-89.8	Pk	28.9	17.5	28.6	46.0	17.4	max. of all, noise; 10 kHz BW
9	1190.0	Hom	Н	-69.0	Pk	20.4	28.0	30.4	54.0	23.6	max. of all, noise
10	1235.0	Horn	Н	-60.0	Pk	20.6	28.0	39.6	54.0	14.4	max. of all
11	1305.0	Horn	Н	-68.0	Pk	20.8	28.2	31.6	54.0	22.4	max. of all, noise
12	1550.0	Horn	Н	-58.5	Pk	21.5	28.2	41.8	54.0	12.2	max. of all
13	1845.0	Horn	Н	-58.5	Pk	22.2	28.1	42.6	54.0	11.4	max. of all
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	Conducted Emissions							
	Freq.	Line	Det.	Vtest	Vlim	Pass		
#	MHz	Side	Used	dΒμV	dΒμV	dB	Comments	
1								
2							Not applicable	
3								

Meas. 7/6/98; U of Mich.



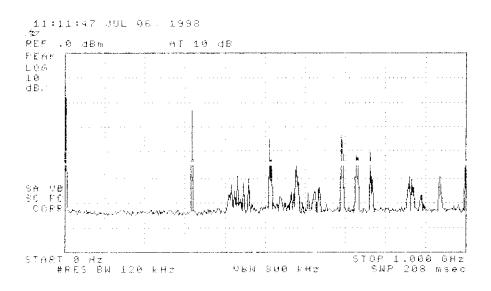
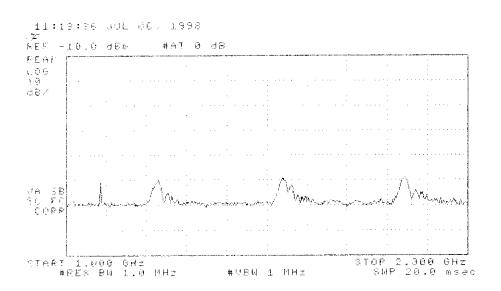


Figure 5.1. Emissions measured at 3 meters in anechoic chamber, 0-1000 MHz. (top) Receiver plus ambient (bottom) Ambient



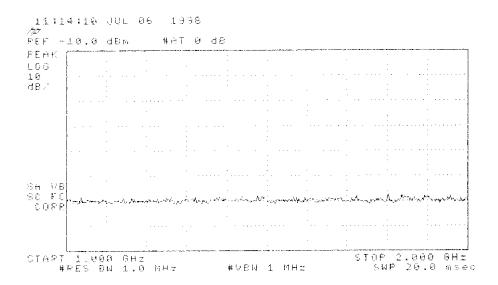


Figure 5.2. Emissions measured at 3 meters in anechoic chamber, 1000-2000 MHz. (top) Receiver plus ambient (bottom) Ambient

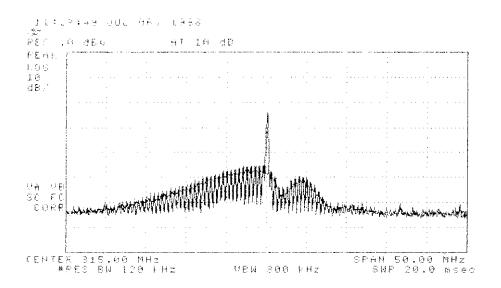


Figure 6.1. Relative receiver emissions in stand-by and "locked-in" modes.

The final emission measurements were made with the receiver in "locked-in" mode.

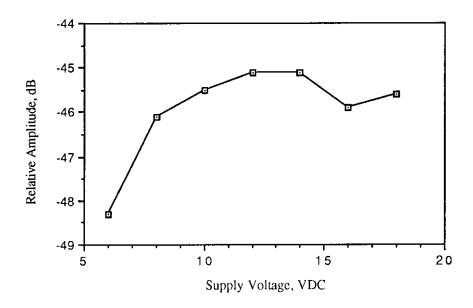


Figure 6.2. Relative emission at "fundamental" vs. supply voltage.